Power MOSFET

60 V, 13 m Ω , 58 A, Dual N–Channel Logic Level, Dual SO–8FL

Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVMFD5873NLWF Wettable Flanks Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- This is a Pb–Free Device

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	60	V
Gate-to-Source Voltage)		V_{GS}	±20	V
Continuous Drain Current R _{ΨJ-mb} (Notes 1,	Steady State	$T_{mb} = 25^{\circ}C$	I _D	58	Α
2, 3, 4)		T _{mb} = 100°C		41	
Power Dissipation		T _{mb} = 25°C	P_{D}	107	W
$R_{\Psi J-mb}$ (Notes 1, 2, 3)		T _{mb} = 100°C		54	
Continuous Drain Cur-		T _A = 25°C	I _D	10	Α
rent R _{θJA} (Notes 1, 3 & 4) Power Dissipation	Steady State	T _A = 100°C		7.0	
		T _A = 25°C	P_{D}	3.1	W
R _{θJA} (Notes 1 & 3)		T _A = 100°C		1.6	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	190	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 175	°C
Source Current (Body Diode)			I _S	58	Α
Single Pulse Drain–to–Source Avalanche Energy (T _J = 25° C, V _{GS} = 10 V, I _{L(pk)} = 28.3 A, L = 0.1 mH, R _G = 25 Ω)		E _{AS}	40	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		T_L	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Mounting Board (top) – Steady State (Notes 2, 3)	$R_{\Psi J-mb}$	1.4	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	48	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 4. Maximum current for pulses as long as 1 second are higher but are dependent on pulse duration and duty cycle.

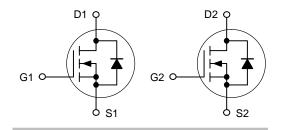


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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
60 V	13 mΩ @ 10 V	58 A	
	16.5 mΩ @ 4.5 V	30 A	

Dual N-Channel







5873NL = Specific Device Code for NVMFD5873NL

5873LW = Specific Device Code for NVMFD5873NLWF

A = Assembly Location

Y = Year W = Work Week ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping [†]
NVMFD5873NLT1G	DFN8 (Pb-Free)	1500 / Tape & Reel
NVMFD5873NLWFT1G	DFN8 (Pb-Free)	1500 / Tape & Reel

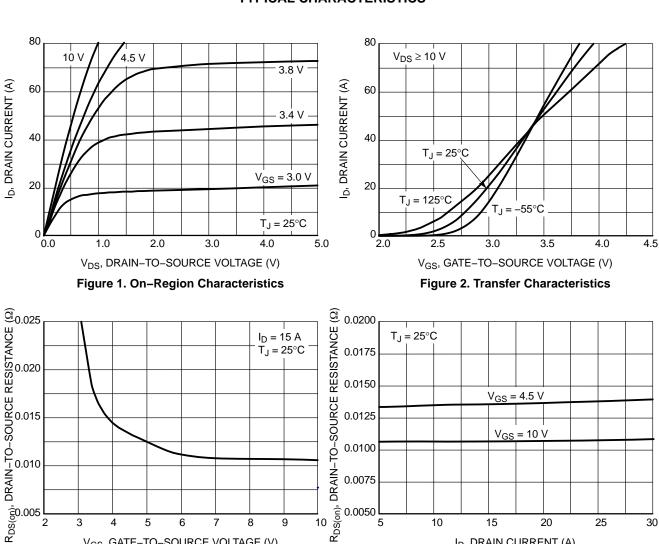
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condit	ion	Min	Тур	Max	Unit
OFF CHARACTERISTICS			•		•		•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				54.9		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 60 \text{ V}$	T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} :	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	250 μΑ	1.5		2.5	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.8		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	= 15 A		10.7	13	mΩ
		V _{GS} = 4.5 V, I _D = 10 A			13.6	16.5	
Forward Transconductance	9 _{FS}	$V_{DS} = 5.0 \text{ V}, I_{D}$	= 15 A		15		S
CHARGES AND CAPACITANCES			•			•	
Input Capacitance	C _{iss}				1560		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MH	z, V _{DS} = 25 V		145		
Reverse Transfer Capacitance	C _{rss}	00 / 50			98		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V},$ $I_{D} = 15 \text{ A}$			16.5		nC
Threshold Gate Charge	Q _{G(TH)}				1.3		1
Gate-to-Source Charge	Q_{GS}				4.0		1
Gate-to-Drain Charge	Q_GD		-		8.8		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48V, I _D = 15 A			30.5		nC
SWITCHING CHARACTERISTICS (No	ote 6)						
Turn-On Delay Time	t _{d(on)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 2.5 \Omega$			10.8		ns
Rise Time	t _r				51		1
Turn-Off Delay Time	t _{d(off)}				21		
Fall Time	t _f				42.6		
Turn-On Delay Time	t _{d(on)}				9.5		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS}	= 48 V,		13		
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = 10 \text{ V}, V_{DS} = 48 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 2.5 \Omega$			25		1
Fall Time	t _f				6.6		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$	$T_J = 25^{\circ}C$		0.8	1.0	V
		$V_{GS} = 0 \text{ V},$ $I_{S} = 15 \text{ A}$	T _J = 125°C		0.7		7
Reverse Recovery Time	t _{RR}	<u> </u>			22.4		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = 15 \text{ A}$			14.5		1
Discharge Time	t _b				9.0		1
Reverse Recovery Charge	Q _{RR}				18		nC

^{5.} Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

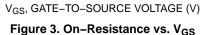
TYPICAL CHARACTERISTICS



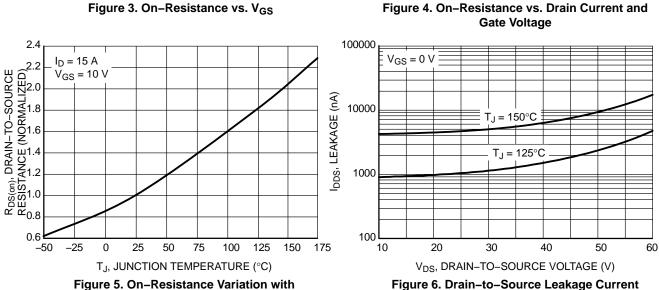
 $V_{GS} = 10 \text{ V}$

ID, DRAIN CURRENT (A)

vs. Voltage



Temperature



R_{DS(on)}, I 0.0050

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TYPICAL CHARACTERISTICS

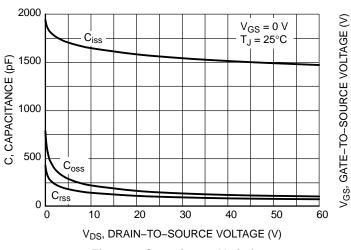


Figure 7. Capacitance Variation

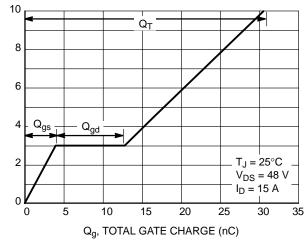


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

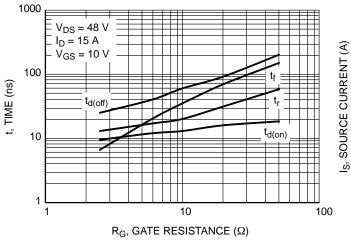


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

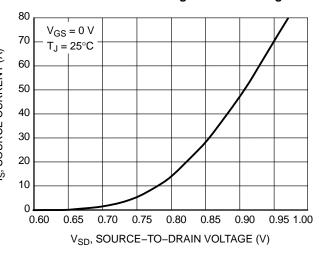


Figure 10. Diode Forward Voltage vs. Current

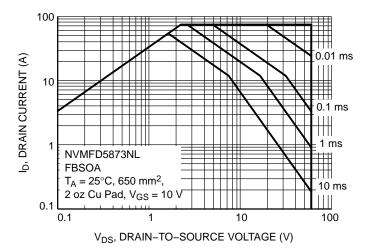


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

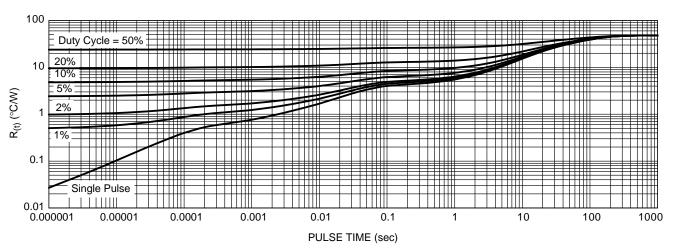
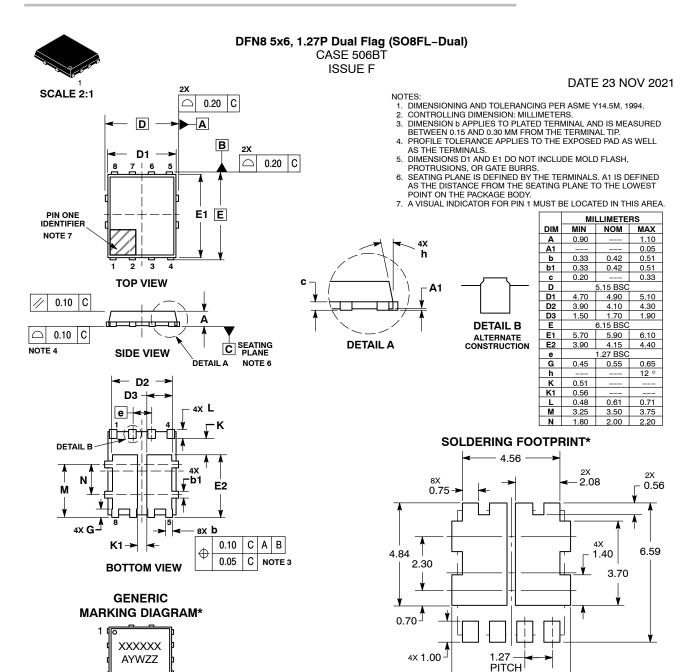


Figure 12. Thermal Response





*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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*Tł	nis information is generic. Please refer to
d	evice data sheet for actual part marking.
Ρ	b-Free indicator, "G" or microdot "■", may
0	r may not be present. Some products may
n	ot follow the Generic Marking.

XXXXXX = Specific Device Code

= Work Week

= Lot Traceability

= Year

Υ

W

77

DOCUMENT NUMBER:

= Assembly Location

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DESCRIPTION: DFN8 5X6, 1.27P DUAL FLAG (SO8FL-DUAL)

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